Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | SAITO, HIROYUKI | Examiner | Art Unit | John L. Shew | 2616 | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | Α | US-6,538,991 B1 | 03-2003 | Kodialam et al. | 370/229 |
| * | В | US-6,795,399 B1 | 09-2004 | Benmohamed et al. | 370/235 |
| * | С | US-6,721,270 B1 | 04-2004 | Mitra et al. | 370/230 |
| * | D | US-6,519,693 B1 | 02-2003 | Debey, Henry C. | 712/201 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | Н | US- | | | |
| | ı | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | α | | | | | |
| | R | | | | | |
| | S | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | ٧ | |
| | w | |
| | х | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.